

Final Product/Process Change Notification Document #: FPCN21779X

Issue Date: 4 July 2017

Title of Change:		Wire conversion from 0.8 mils Au wire to 0.8 mils bare Cu wire for SOT23 SL05 devices.						
Proposed first ship date:		11 October 2017						
Contact information:		Contact your local ON Semiconductor Sales Office or < contact your local ON Semiconductor Sales Office or < contact your local ON Semiconductor Sales Office or < contact your local ON Semiconductor Sales Office or < contactyourlocal-on-semicom>						
Samples:		Contact your local ON Semiconductor Sales Office						
Additional Reliability Data:		Contact your local ON Semiconductor Sales Office or < Rui.Zhang@onsemi.com >.						
Type of notification:		This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <pcn.support@onsemi.com>.</pcn.support@onsemi.com>						
Change Part	Identification:	After expired of the FPCN, devices will be assembled with 0.8 mils bare Cu Wire at ON Semiconductor's existing Leshan facility. Products assembled with 0.8 mils bare Cu Wire from the ON Semiconductor facility will have a Finish Goods Date Code of WW38, 2017 or greater.						
Change cate	gory:	☐ Wafer Fa	ab Change	Assembly Change	Test Change	Other _Wire Bonding	<u>change</u>	
Manufa	-Category(s): cturing Site Change cturing Process Cha		⊠ Material □ Product s	Change pecific change	☐ Sh	atasheet/ProductDoc chang hipping/Packaging/Marking her:	;e 	
Sites Affected: All site(s) not applicable ON Semiconductor site(s): ON Leshan, China External Foundry/Subcon site(s)							s)	
Description and Purpose:								
ON Semiconductor is notifying customer of its use 0.8 mils bare Cu wire for SOT23 SL05 series device at ON Semiconductor's Les han, China facility. Upon the expiration of the PCN, devices will be built with 0.8 mils bare Cu wire at the same site. Datasheet specifications and product electrical performance remain unchanged. Reliability Qualification and full electrical characterization over temperature have been performed.								
performance remain anonanged. Nemability Quantication and fun electrical characterization over temperature have been performed.								
	Material to be	changed	Bef	ore Change Description	Afte	r Change Description		
	Bonding Wire			0.8mil Au Wire		0.8mil Cu Wire]	

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Reliability Data Summary:

Qualification Vehicle: SZSL24T1G PACKAGE: SOT23

Test	Specification	Condition	Interval	Results
PC	JESD22-A113	MSL 1@ 260°C	Before TC, AC, H3TRB, IOL	0/924
AC	JESD22-A102	121°C, 100% RH, ~15psig, unbiased	192 hrs	0/231
TC	JESD22-A104	Ta= - 65°C to +150°C	2000 сус	0/231
H3TRB	JESD22-A101	85°C, 85% RH, V=80% rated V or 100V max.	2016 hrs	0/231
IOL	MIL-STD-750 (M1037)	Ta=+25°C, delta Tj=100°C On/off = 2 min	30000 cyc	0/231
HTRB	MIL-STD750-1	Tj= max, V=100% rated V, 1008 Hrs	1008	0/231
HTSL	JEDS22- A103	Temp.=165°C,no bias,2016hours	2016hrs	0/231
RSH	JESD22- B106	Ta = 265C, 10 sec	-	0/30

Electrical Characteristic Summary:

 $Three\ temperature\ characterization\ and\ ESD\ performance\ meet\ data sheet\ specification.\ Detail\ of\ Electrical\ characterization\ re\ sult is\ available$ upon request.

List of Affected Standard Parts:

Part Number	Qualification Vehicle	
SL05T1G	SZSL24T1G	
SL12T1G		
SL15T1G		
SL24T1G		

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